

FDM3622

N-Channel PowerTrench® MOSFET

100V, 4.4A, 60mΩ

Features

- $r_{DS(ON)} = 44m\Omega$ (Typ.), $V_{GS} = 10V$, $I_D = 4.4A$
- $Q_g(tot) = 13nC$ (Typ.), $V_{GS} = 10V$
- Low Miller Charge
- Low Q_{RR} Body Diode
- Optimized efficiency at high frequencies
- UIS Capability (Single Pulse and Repetitive Pulse)

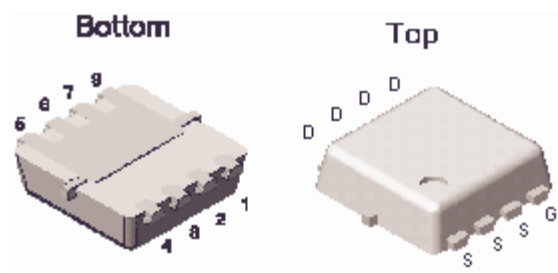
Applications

- Distributed Power Architectures and VRMs
- Primary Switch for 24V and 48V Systems
- High Voltage Synchronous Rectifier

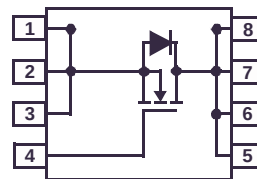
Formerly developmental type 82744

General Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.



MicroFET 3.3 x 3.3



MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
V_{DS}	Drain to Source Voltage	100	V
V_{GS}	Gate to Source Voltage	± 20	V
I_D	Drain Current		
	Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$, $R_{\theta JA} = 52^\circ\text{C/W}$)	4.4	A
	Continuous ($T_C = 25^\circ\text{C}$, $V_{GS} = 6\text{V}$, $R_{\theta JA} = 52^\circ\text{C/W}$)	3.8	
	Continuous ($T_C = 100^\circ\text{C}$, $V_{GS} = 10\text{V}$, $R_{\theta JA} = 52^\circ\text{C/W}$)	2.8	A
	Pulsed	Figure 4	A
E_{AS}	Single Pulse Avalanche Energy (Note 2)	190	mJ
P_D	Power dissipation	2.4	W
	Derate above 25°C	19	mW/ $^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature	-55 to 150	$^\circ\text{C}$

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 1a)	52	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance Junction to Ambient (Note 1b)	108	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction to Case (Note 1)	1.8	$^\circ\text{C/W}$

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDM3622	FDM3622	MicroFET3.3x3.3	7"	12mm	3000 units

Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

Off Characteristics

B_{VDS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}$, $V_{GS} = 0\text{V}$	100	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 80\text{V}$ $V_{GS} = 0\text{V}$	-	-	1	μA
		$T_C = 100^\circ\text{C}$	-	-	250	
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(TH)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu\text{A}$	2	-	4	V
$r_{DS(ON)}$	Drain to Source On Resistance	$I_D = 4.4\text{A}$, $V_{GS} = 10\text{V}$	-	0.044	0.060	Ω
		$I_D = 3.8\text{A}$, $V_{GS} = 6\text{V}$	-	0.056	0.080	
		$I_D = 4.4\text{A}$, $V_{GS} = 10\text{V}$, $T_C = 150^\circ\text{C}$	-	0.092	0.120	

Dynamic Characteristics

C_{ISS}	Input Capacitance	$V_{DS} = 25\text{V}$, $V_{GS} = 0\text{V}$, $f = 1\text{MHz}$	-	820	-	pF
C_{OSS}	Output Capacitance		-	125	-	pF
C_{RSS}	Reverse Transfer Capacitance		-	35	-	pF
R_G	Gate Resistance	$V_{GS} = 0.5\text{V}$, $f = 1\text{MHz}$	-	3.1	-	Ω
$Q_{g(TOT)}$	Total Gate Charge at 10V	$V_{GS} = 0\text{V}$ to 10V	-	13	17	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0\text{V}$ to 2V	-	1.6	2.1	nC
Q_{gs}	Gate to Source Gate Charge	$V_{DD} = 50\text{V}$ $I_D = 4.4\text{A}$ $I_g = 1.0\text{mA}$	-	3.6	-	nC
Q_{gs2}	Gate Charge Threshold to Plateau		-	2.0	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	3.4	-	nC

Resistive Switching Characteristics ($V_{GS} = 10V$)

t_{ON}	Turn-On Time	$V_{DD} = 50V, I_D = 4.4A$ $V_{GS} = 10V, R_{GS} = 24\Omega$	-	-	54	ns
$t_{d(ON)}$	Turn-On Delay Time		-	11	-	ns
t_r	Rise Time		-	25	-	ns
$t_{d(OFF)}$	Turn-Off Delay Time		-	35	-	ns
t_f	Fall Time		-	26	-	ns
t_{OFF}	Turn-Off Time		-	-	92	ns

Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Voltage	$I_{SD} = 4.4A$	-	-	1.25	V
		$I_{SD} = 2.2A$	-	-	1.0	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 4.4A, dI_{SD}/dt = 100A/\mu s$	-	-	56	ns
Q_{RR}	Reverse Recovered Charge	$I_{SD} = 4.4A, dI_{SD}/dt = 100A/\mu s$	-	-	108	nC

Notes:

- $R_{\theta JA}$ is determined with the device mounted on a $1in^2$ 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.
 - $R_{\theta JA} = 52^\circ C/W$ when mounted on a $1in^2$ pad of 2 oz. copper.
 - $R_{\theta JA} = 108^\circ C/W$ when mounted on a minimum pad of 2 oz. copper
- Starting $T_J = 25^\circ C$, $L = 31mH$, $I_{AS} = 3.5A$, $V_{DD} = 100V$

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

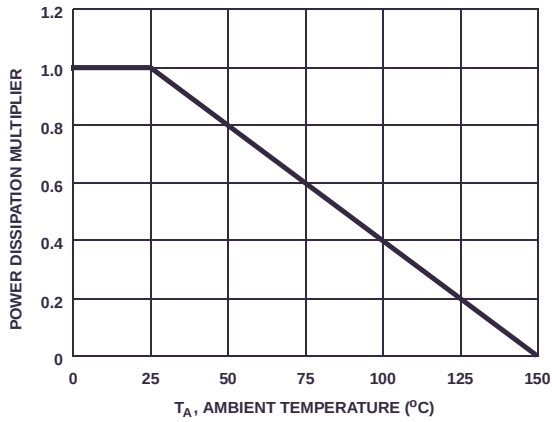


Figure 1. Normalized Power Dissipation vs Ambient Temperature

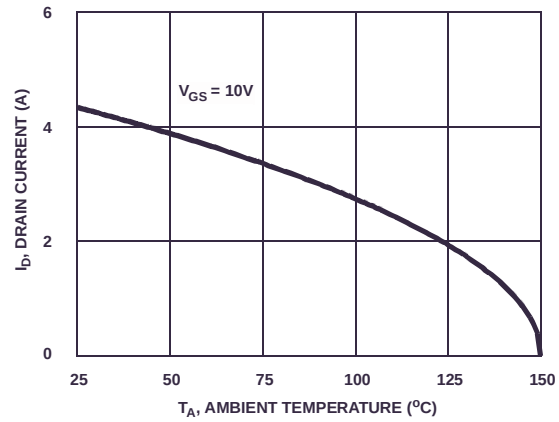


Figure 2. Maximum Continuous Drain Current vs Ambient Temperature

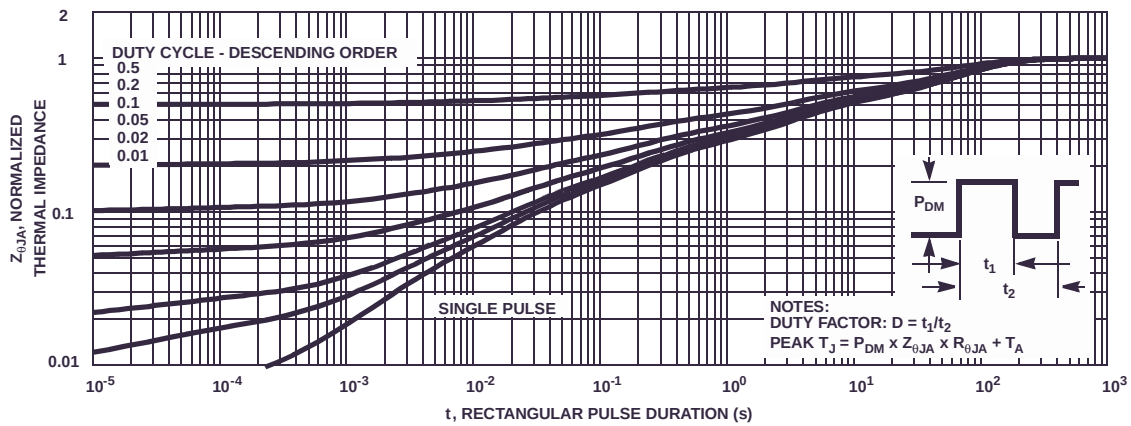


Figure 3. Normalized Maximum Transient Thermal Impedance

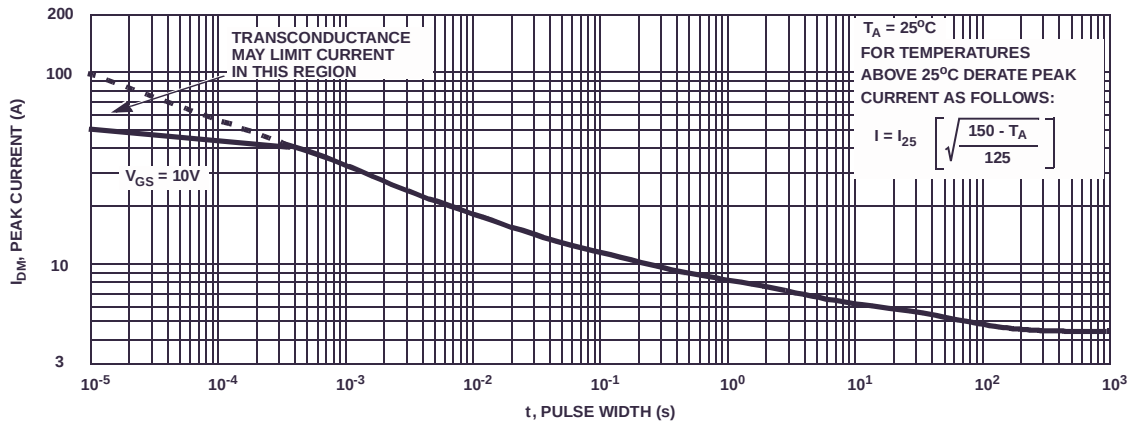


Figure 4. Peak Current Capability

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

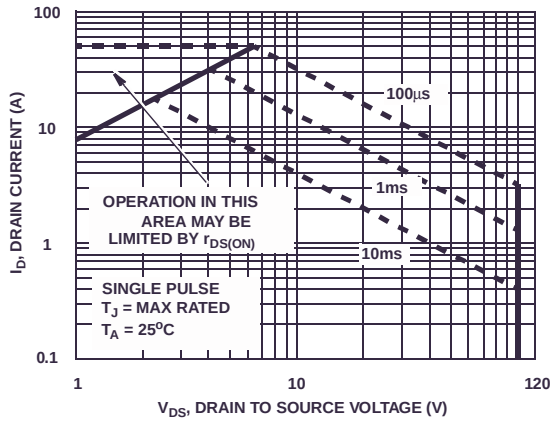
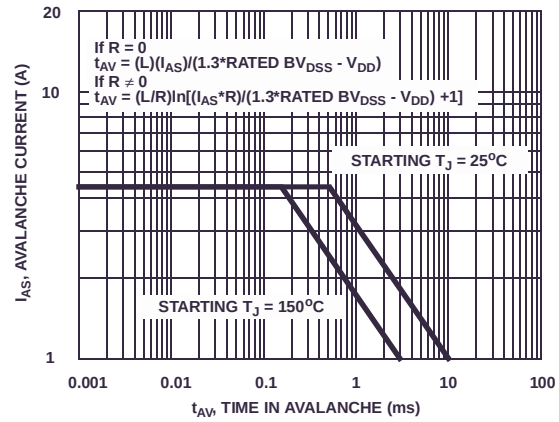


Figure 5. Forward Bias Safe Operating Area



NOTE: Refer to Fairchild Application Notes AN7514 and AN7515
Figure 6. Unclamped Inductive Switching Capability

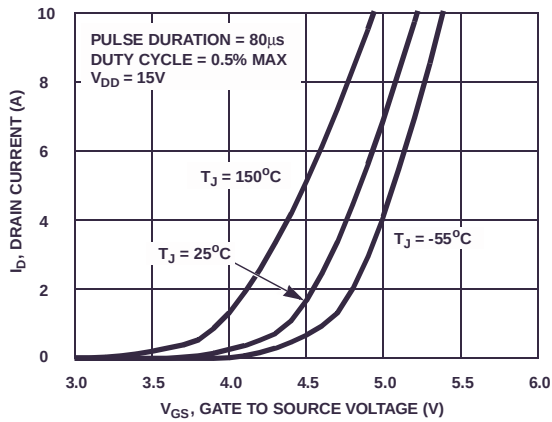


Figure 7. Transfer Characteristics

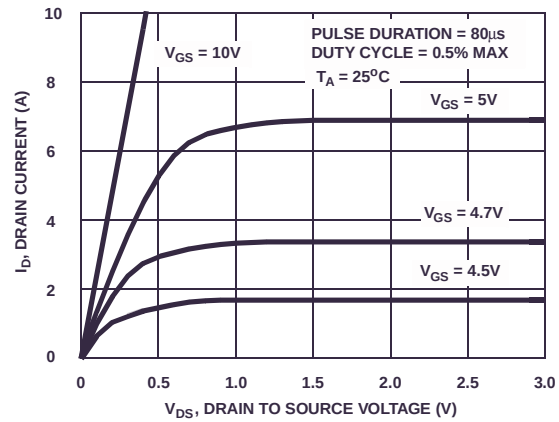


Figure 8. Saturation Characteristics

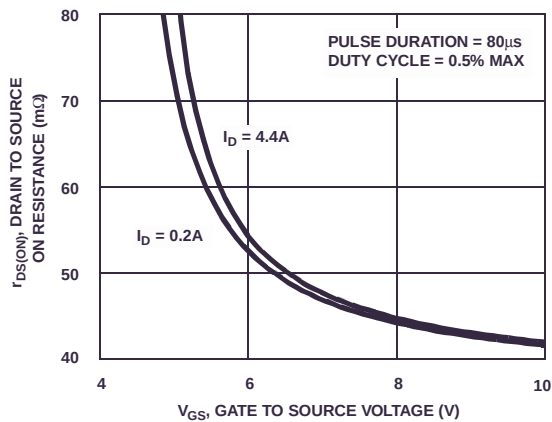


Figure 9. Drain to Source On Resistance vs Gate Voltage and Drain Current

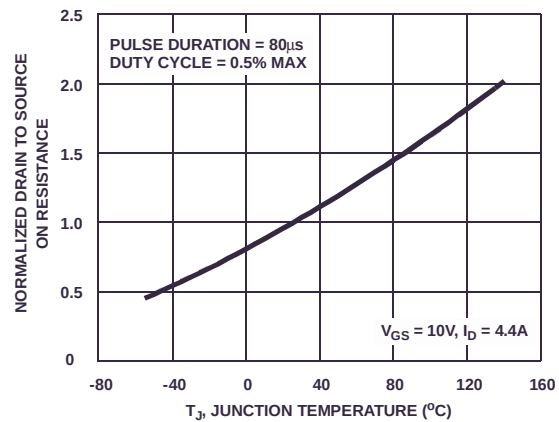


Figure 10. Normalized Drain to Source On Resistance vs Junction Temperature

Typical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

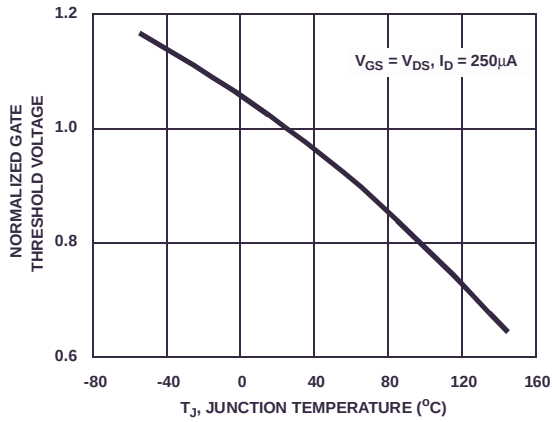


Figure 11. Normalized Gate Threshold Voltage vs Junction Temperature

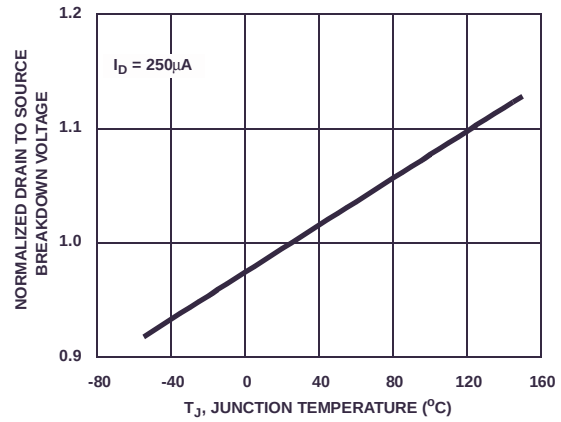


Figure 12. Normalized Drain to Source Breakdown Voltage vs Junction Temperature

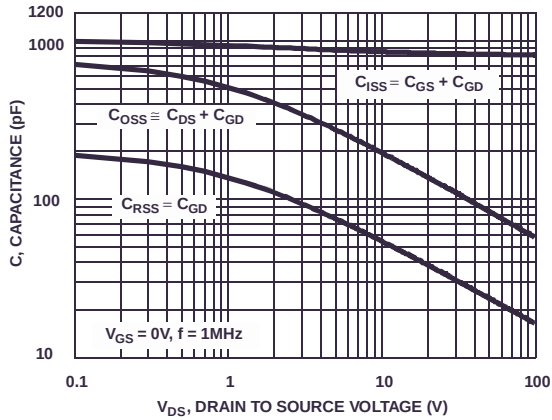


Figure 13. Capacitance vs Drain to Source Voltage

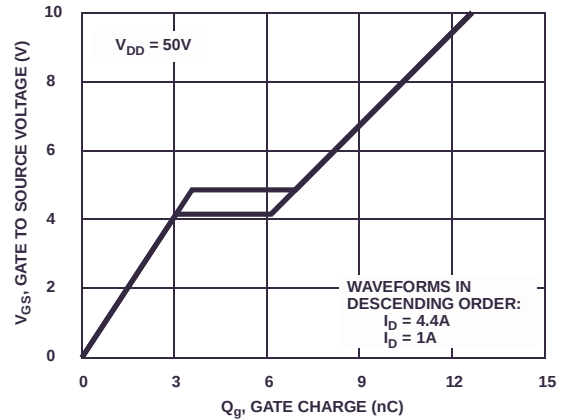


Figure 14. Gate Charge Waveforms for Constant Gate Currents

Test Circuits and Waveforms

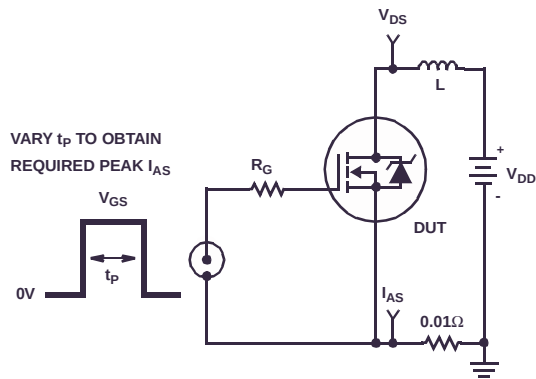


Figure 15. Unclamped Energy Test Circuit

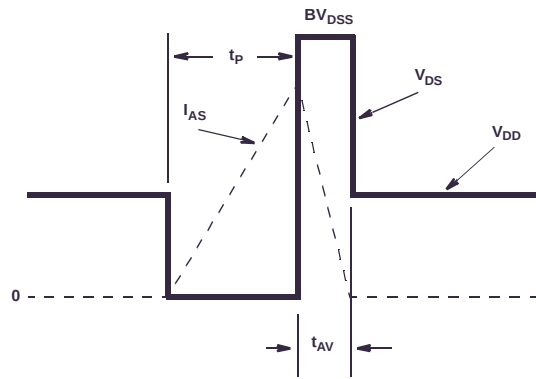


Figure 16. Unclamped Energy Waveforms

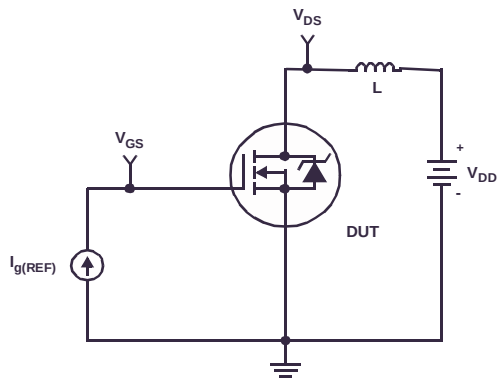


Figure 17. Gate Charge Test Circuit

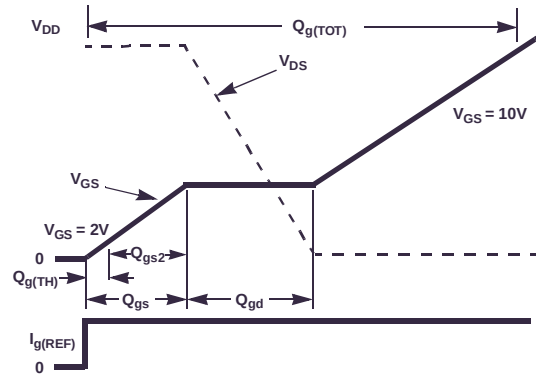


Figure 18. Gate Charge Waveforms

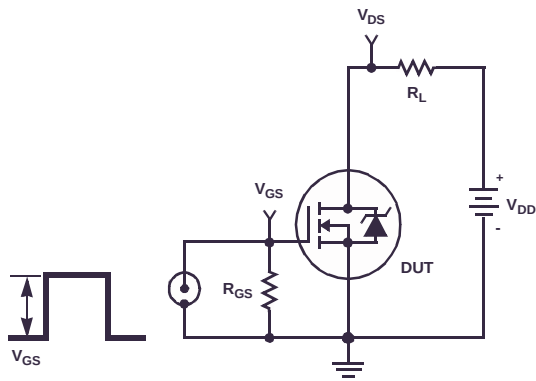


Figure 19. Switching Time Test Circuit

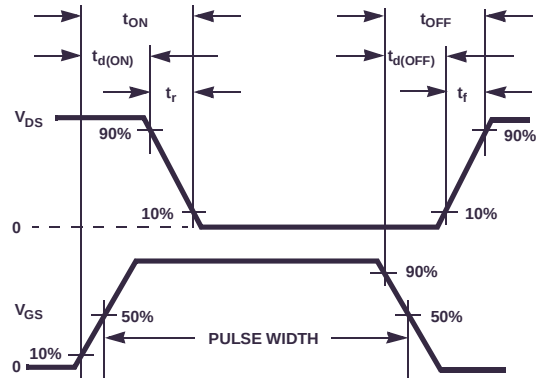


Figure 20. Switching Time Waveforms

SABER Electrical Model

REV October 2004

ttemplate FDM3622 n2,n1,n3

electrical n2,n1,n3

```
{
var i iscl
dp..model dbodymod = (isl=1.2e-12,rs=9.4e-3,trs1=2.0e-3,trs2=4.5e-7,cjo=5.5e-10,m=0.56,tt=4.4e-8,xti=4.0)
dp..model dbreakmod = (rs=0.6,trs1=1.4e-3,trs2=-5.0e-5)
dp..model dplcapmod = (cjo=2.0e-10,isl=10.0e-30,nl=10,m=0.54)
m..model mmedmod = (type=_n,vto=3.58,kp=2.8,is=1e-30, tox=1)
m..model mstrongmod = (type=_n,vto=4.26,kp=32,is=1e-30, tox=1)
m..model mweakmod = (type=_n,vto=3.12,kp=0.04,is=1e-30, tox=1,rs=0.1)
sw_vcsp..model s1amod = (ron=1e-5,roff=0.1,von=-6.0,voff=-2.0)
sw_vcsp..model s1bmod = (ron=1e-5,roff=0.1,von=-2.0,voff=-6.0)
sw_vcsp..model s2amod = (ron=1e-5,roff=0.1,von=-0.5,voff=0.3)
sw_vcsp..model s2bmod = (ron=1e-5,roff=0.1,von=0.3,voff=-0.5)
c.ca n12 n8 = 2.5e-10
c.cb n15 n14 = 2.5e-10
c.cin n6 n8 = 8e-9
```

```
dp.dbody n7 n5 = model=dbodymod
dp.dbreak n5 n11 = model=dbreakmod
dp.dplcap n10 n5 = model=dplcapmod
```

```
spe.ebreak n11 n7 n17 n18 = 109
spe.eds n14 n8 n5 n8 = 1
spe.egs n13 n8 n6 n8 = 1
spe.esg n6 n10 n6 n8 = 1
spe.evthres n6 n21 n19 n8 = 1
spe.evtemp n20 n6 n18 n22 = 1
```

```
i.it n8 n17 = 1
```

```
l.lgate n1 n9 = 1.06e-9
l.ldrain n2 n5 = 1.0e-9
l.lsource n3 n7 = 0.19e-9
```

```
res.rlgate n1 n9 = 10.6
res.rldrain n2 n5 = 10
res.rlsource n3 n7 = 1.9
```

```
m.mmed n16 n6 n8 n8 = model=mmedmod, l=1u, w=1u
m.mstrong n16 n6 n8 n8 = model=mstrongmod, l=1u, w=1u
m.mweak n16 n21 n8 n8 = model=mweakmod, l=1u, w=1u
```

```
res.rbreak n17 n18 = 1, tc1=1.05e-3,tc2=-1.1e-8
res.rdrain n50 n16 = 9e-3, tc1=3.0e-2,tc2=5e-5
res.rgate n9 n20 = 3.16
res.rslc1 n5 n51 = 1.0e-6, tc1=3.0e-3,tc2=2.9e-6
res.rslc2 n5 n50 = 1.0e3
res.rsource n8 n7 = 27.7e-3, tc1=1.0e-3,tc2=1.0e-6
res.rvthres n22 n8 = 1, tc1=-3.9e-3,tc2=-1.4e-5
res.rvtemp n18 n19 = 1, tc1=-3.4e-3,tc2=1.8e-7
sw_vcsp.s1a n6 n12 n13 n8 = model=s1amod
sw_vcsp.s1b n13 n12 n13 n8 = model=s1bmod
sw_vcsp.s2a n6 n15 n14 n13 = model=s2amod
sw_vcsp.s2b n13 n15 n14 n13 = model=s2bmod
```

```
v.vbat n22 n19 = dc=1
```

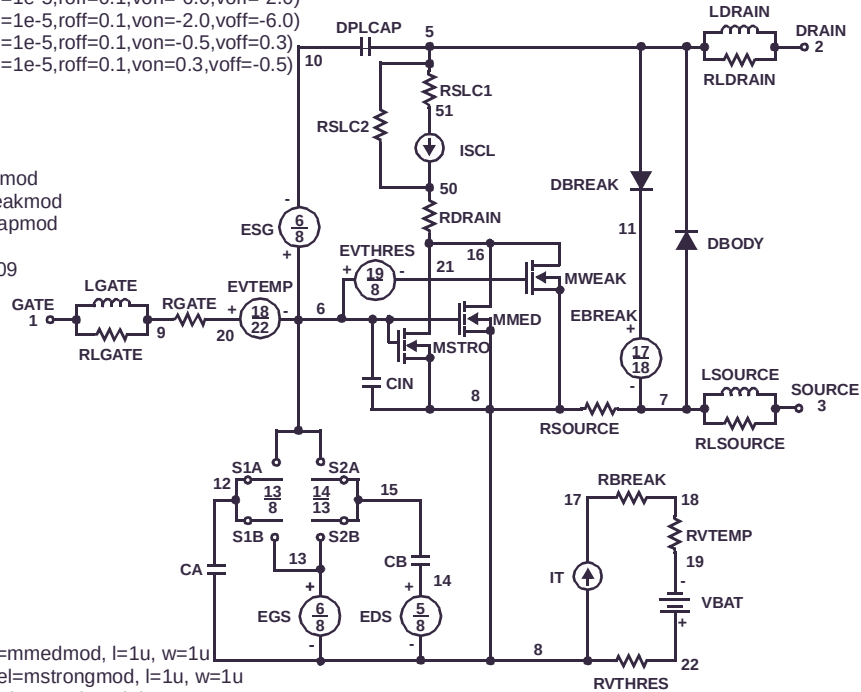
```
equations {
```

```
  i (n51->n50) +=iscl
```

```
  iscl: v(n51,n50) = (((v(n5,n51)/(1e-9+abs(v(n5,n51))))*((abs(v(n5,n51)*1e6/70))** 2.5))
```

```
  }
```

```
}
```



SPICE Thermal Model

REV October 2004

FDM3622_JA Junction Ambient
Copper Area = 1sq.in

CTHERM1 TH c2 1.1e-4
CTHERM2 c2 c3 1.2e-4
CTHERM3 c3 c4 3.0e-4
CTHERM4 c4 c5 2.0e-3
CTHERM5 c5 c6 6.4e-3
CTHERM6 c6 c7 3.2e-2
CTHERM7 c7 c8 2.9e-1
CTHERM8 c8 Ambient 3

RTHERM1 TH c2 2.0e-2
RTHERM2 c2 c3 1.3e-1
RTHERM3 c3 c4 2.0e-1
RTHERM4 c4 c5 1.1
RTHERM5 c5 c6 3.3
RTHERM6 c6 c7 6.8
RTHERM7 c7 c8 12.2
RTHERM8 c8 Ambient 27

SABER Thermal Model

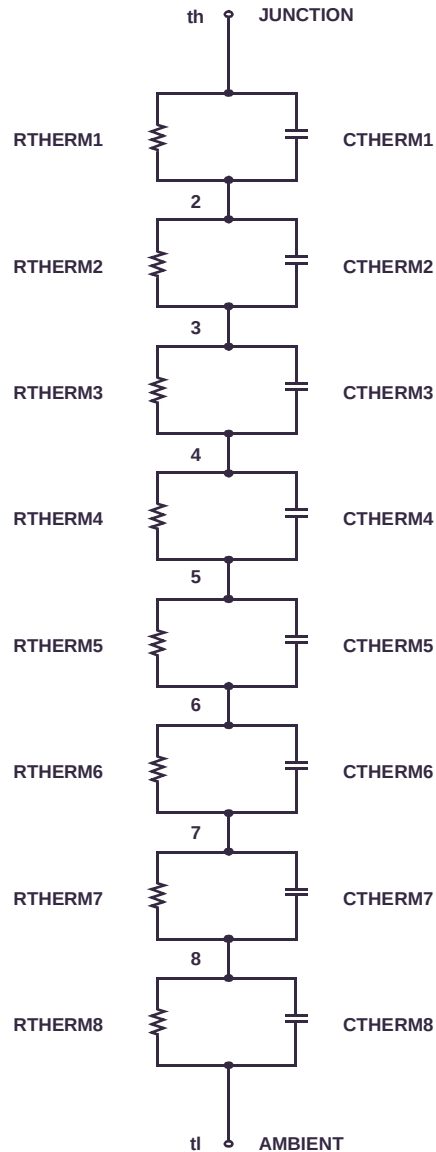
SABER thermal model FDM3622

Copper Area = 1sq.in

template thermal_model th tl
thermal_c th, tl

```
{
  ctherm.ctherm1 th c2 =1.1e-4
  ctherm.ctherm2 c2 c3 =1.2e-4
  ctherm.ctherm3 c3 c4 =3.0e-4
  ctherm.ctherm4 c4 c5 =2.0e-3
  ctherm.ctherm5 c5 c6 =6.4e-3
  ctherm.ctherm6 c6 c7 =3.2e-2
  ctherm.ctherm7 c7 c8 =2.9e-1
  ctherm.ctherm8 c8 tl =3
}
```

```
rrtherm.rtherm1 th c2 =2.0e-2
rtherm.rtherm2 c2 c3 =1.3e-1
rtherm.rtherm3 c3 c4 =2.0e-1
rtherm.rtherm4 c4 c5 =1.1
rtherm.rtherm5 c5 c6 =3.3
rtherm.rtherm6 c6 c7 =6.8
rtherm.rtherm7 c7 c8 =12.2
rtherm.rtherm8 c8 tl =27
}
```



TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACE ^{Ex} ™	FACT Quiet Series™	ImpliedDisconnect™	POP™	Stealth™
ActiveArray™	FAST®	IntelliMAX™	Power247™	SuperFET™
Bottomless™	FASTr™	ISOPLANAR™	PowerEdge™	SuperSOT™-3
CoolFET™	FPST™	LittleFET™	PowerSaver™	SuperSOT™-6
CROSSVOLT™	FRFET™	MICROCOUPLER™	PowerTrench®	SuperSOT™-8
DOVE™	GlobalOptoisolator™	MicroFET™	QFET®	SyncFET™
EcoSPARK™	GTO™	MicroPak™	QS™	TinyLogic®
E ² C ² MOS™	HiSeC™	MICROWIRE™	QT Optoelectronics™	TINYOPTO™
EnSigna™	I ² C™	MSX™	Quiet Series™	TruTranslation™
FACT™	i-Lo™	MSXPro™	RapidConfigure™	UHC™
		OCX™	RapidConnect™	UltraFET®
Across the board. Around the world.™		OCXPro™	µSerDes™	UniFET™
The Power Franchise®		OPTOLOGIC®	SILENT SWITCHER®	VCX™
Programmable Active Droop™		OPTOPLANAR™	SMART START™	
		PACMAN™	SPM™	

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.
2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.